

Product Change Notification / GBNG-03JWKQ486

Date:

09-Nov-2021

Product Category:

32-bit Microcontrollers

PCN Type:

Manufacturing Change

Notification Subject:

CCB 4443 Final Notice: Qualification of G631HQ mold compound material for selected Atmel AT32UC3Axxx and AT32UC3Cxxx device families available in 144L LQFP (20x20x1.4mm) package at ANAP assembly site.

Affected CPNs:

GBNG-03JWKQ486_Affected_CPN_11092021.pdf GBNG-03JWKQ486_Affected_CPN_11092021.csv

Notification Text:

PCN Status: Final notification

PCN Type: Manufacturing Change

Microchip Parts Affected: Please open one of the files found in the Affected CPNs section.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:Qualification of G631HQ mold compound material for selected Atmel AT32UC3Axxx and AT32UC3Cxxx device families available in 144L LQFP (20x20x1.4mm) package at ANAP assembly site.

Pre and Post Change Summary:

	Pre Change	Post Change
Assembly Site	Amkor Technology Philippine	Amkor Technology Philippine

	(P1/P2), IN	IC. / ANAP	(P1/P2), INC. / ANAP		
Wire material	AuPd		AuPd		
Die attach material	3230		3230		
Molding compound material	G700L		G631HQ		
Lead frame material	C194		C194		C194
Lead frame paddle size	276x276 mils 236x236 mils		276x276 mils		
Lead frame design	See attached pre and post change comparison				

Impacts to Data Sheet: None

Change ImpactNone

Reason for Change:To improve manufacturability by qualifying G631HQ mold compound material with 276x276 mils lead frame paddle size at ANAP assembly site.

Change Implementation Status: In Progress

Estimated First Ship Date: December 10, 2021 (date code: 2150)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts

Time Table Summary:

	November 2021			December 2021					
Workweek	45	46	47	48	49	50	5 1	52	5 3
Qual Report Availability		Х							
Final PCN Issue Date		х							
Estimated First Ship Date						х			

Method to Identify Change: Traceability code

Qualification Report:Please open the attachments included with this PCN labeled as PCN_#_Qual Report.

Revision History:November 5, 2020: Issued initial notification.**November 9, 2021:** Issued final notification. Attached the qualification report and added estimated first ship date by December 10, 2021.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products

Attachments:

PCN_GBNG-03JWKQ486_Qual Report.pdf PCN_GBNG-03JWKQ486_Pre and Post Change Summary.pdf

Please contact your local Microchip sales office with questions or concerns regarding this notification.

Terms and Conditions:

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our PCN home page select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the PCN FAQ section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

PCN #: GBNG-03JWKQ486

PRE AND POST CHANGE SUMMARY CCB 4443

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Lead frame Comparison

	Pre Change			ost Change
$\label{eq:relation} \begin{split} & \ensuremath{w} w \\ & \ens$				
Strip Density	HDLF High Density Lead frame	HDLF High Density Lead frame	Strip Density	UDLF Ultra Density Lead frame
LF Paddle Size	276x276 mils	236x236 mils	LF Paddle Sie	276x276 mils
DAP Surface Prep Double Ring Ag Double Ring Ag		Double Ring Ag	DAP Surface Prep	Double Ring Ag
Backside Dimple Yes Yes			Backside Dimple	No





QUALIFICATION REPORT SUMMARY

PCN#: GBNG-03JWKQ486

Date: September 24, 2021

Qualification of G631HQ mold compound material for selected Atmel AT32UC3Axxx and AT32UC3Cxxx device families available in 144L LQFP (20x20x1.4mm) package at ANAP assembly site. Q-100 Automotive Grade 1

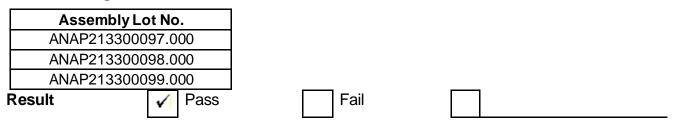


Purpose: Qualification of G631HQ mold compound material for selected Atmel AT32UC3Axxx and AT32UC3Cxxx device families available in 144L LQFP (20x20x1.4mm) package at ANAP assembly site.

	Qual ID	QTP4442 Rev. A
	Assembly site	ANAP
	BD Number	BDM-002758A
	MP Code (MPC)	58U94YH8XC02
Misc.	Part Number (CPN)	AT32UC3C0512C-ALZR
IVIISC.	MSL information	MSL-3 @260C
	Assembly Shipping Media (T/R, Tube/Tray)	T/R
	Base Quantity Multiple (BQM)	800 units
	Reliability Site	MPHIL
	CCB#	4443
	Paddlesize	276x276 mils
	Material	C194
	DAP Surface Prep	Double Ring Ag
	Treatment	None
Lead-Frame	Process	STAMPED
	Lead-lock	Yes
	Part Number	101384548
	Lead Plating	Matte Tin
	Strip Density	UDLF
Bond Wire	Material	AuPd
Die Attach	Part Number	3230
Die Attach	Conductive	Yes
MC	Part Number	G631HQ
	PKG Type	LQFP
PKG	Pin/Ball Count	144
	PKG width/size	20x20x1.4mm



Manufacturing Information



58U94YH8XC02 using UDLF LF#101384548 and mold compound G631HQ with 0.15um wafer tech. in 144L LQFP 20x20x1.4mm from ANAP pass reliability stress tests per QCI-39000 conducted at MPHL rel lab. This package is qualified Moisture/Reflow Sensitivity Classification Level 3 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard.

	PACKAGE QUALIFICATION REPORT							
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks		
	Electrical Test :25°C Magnum	JESD22- A113,	231 per lot	Lot 1 0/231	Pass	Good Devices		
		JIP/ IPC/JEDE C J-STD-		Lot 2 0/231	Pass			
		020E		Lot 3 0/231	Pass			
	Bake 150°C, 24 hrs System: HERAEUS		231 per lot					
Dressnelition	Moisture Soak 192h(30°C/60%RH) System: Climats Excal 5423-HE		231 per lot					
Precondition Prior Perform Reliability Tests	Reflow 3x Convection-Reflow 265°C max System: Mancorp CR.5000F		231 per lot	Lot 1 0/231	Pass			
(At MSL Level 3)				Lot 2 0/231	Pass			
				Lot 3 0/231	Pass			
	Electrical Test :25°C Magnum		231 per lot	Lot 1 0/231	Pass			
				Lot 2 0/231	Pass			
				Lot 3 0/231	Pass			

	PACKAGE QUALIFICATION REPORT							
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks		
	Stress Condition: (Standard) + 130°C, 85%RH, 96 hrs. System: HIRAYAMA HASTEST PC-422R8	JESD22- A118	77 units per lot	Lot 1 0/77	Pass	Parts had been pre-conditioned at 260°C		
				Lot 2 0/77	Pass			
	Electrical Test: 25°C System: Magnum			Lot 3 0/77	Pass			
UNBIASED HAST	Internal Package Analysis		5 units per lot	Lot 1, 0/5	Pass			
				Lot 2, 0/5	Pass			
				Lot 3, 0/5	Pass			
	Stress Condition: (Standard) 130°C, 85%RH, 96 hrs. VOLTS=5.5V	JESD22- A110	77 units per lot	Lot 1 0/77	Pass			
	System: HIRAYAMA HASTEST PC-422R8			Lot 2 0/77	Pass			
	Electrical Test: 25°C /130°C System: Magnum			Lot 3 0/77	Pass			
HAST	Internal Package Analysis		5 units per lot	Lot 1, 0/5	Pass			
				Lot 2, 0/5	Pass			
				Lot 3, 0/5	Pass			

	PACKAGE QUALIFICATION REPORT							
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks		
	Stress Condition: (Standard) -65°C to +150°C, 500 Cycles System : Votsch VTS ² 7012 Electrical Test: 130°C System: Magnum	JESD22- A104	77 units per lot	Lot 1 0/77 Lot 2 0/77 Lot 3 0/77	Pass Pass Pass	Parts had been pre- conditioned at 260°C		
Temp Cycle	Internal Package Analysis		5 units per lot	Lot 1, 0/5 Lot 2, 0/5	Pass Pass			
				Lot 3, 0/5	Pass			
	Bond Strength: Wire Pull (> 1.75 grams) Bond <i>Shear (>12.6 grams)</i>		5 units, 30 bonds per lot	Lot 1 0/30	Pass			
	System: Dage		periot	Lot 2 0/30	Pass			
				Lot 3 0/30	Pass			
High Temperature Storage Life	Stress Condition: Bake 175°C, 500 hrs System: HERAEUS Electrical Test: 25°C /130°C System: Magnum	JESD22- A103	45 units per lot	Lot 1 0/45	Pass			

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
Bond Strength, 0 Hour	System: Dage Wire Pull (> 1.75 grams) Bond <i>Shear (> 12.6 grams)</i>		5 units, 30 bonds per lot	Lot 1 0/30	Pass	
			poriot	Lot 2 0/30	Pass	
				Lot 3 0/30	Pass	
Solderability	Bake: Temp 155°C,4Hrs System: Oven Solder Bath: Temp.245°C Solder material: SAC305 Visual Inspection: External Visual Inspection	J-STD-002D	22 units from 1 lot	0/22	Pass	
Physical Dimension	Physical Dimension, 30 units from 3 lots	JESD22 -B100/B108	22 units per lot	Lot 1 0/22	Pass	
				Lot 2 0/22	Pass	
				Lot 3 0/22	Pass	

Affected Catalog Part Numbers (CPN)

AT32UC3A0512-ALTTA AT32UC3A0512-ALTRA AT32UC3A3128-ALUT AT32UC3A3128S-ALUT AT32UC3A3256-ALUT AT32UC3A3256S-ALUT AT32UC3A364-ALUT AT32UC3A364S-ALUT AT32UC3A3256-ALUTA1 AT32UC3A3256AU-ALUTA1 AT32UC3A3128-ALUR AT32UC3A3128S-ALUR AT32UC3A3256-ALUR AT32UC3A3256S-ALUR AT32UC3A364-ALUR AT32UC3A364S-ALUR AT32UC3A0512-ALUT AT32UC3A0512-ALUR AT32UC3C0512C-ALZT AT32UC3C0128C-ALUT AT32UC3C0256C-ALUT AT32UC3C0512C-ALUT AT32UC3C064C-ALUT AT32UC3C0128C-ALUR AT32UC3C064C-ALUR AT32UC3C0512C-ALUR AT32UC3C0256C-ALUR AT32UC3C0512C-ALZR AT32UC3A0128-ALUT AT32UC3A0256-ALUT AT32UC3A0128-ALUR AT32UC3A0256-ALUR